

PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

	THE PATE	CLASS	SUBCLASS	GAU		EXAMINER	
APPL NUM	FILING DATE	438	(77)	2812	6	urley	1
10082311	02/26/2002	1	·				
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Tamaru Tsuyo	oshi; Ohmori Kazut	oshi;					
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** FOREIGN	APPLICATIONS	VERIFIE	D:				
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PG-PUB D	O NOT PUBLISH			CIND	LAT	TORNEY DOCKET NO	
Foreign priority	y claimed		lyes □ no Lyes □ no		•		
35 USC 119 c	onditions met cknowledged Examiner		. yes = 110		XA	k-9635	
TITLE : Ma	nufacturing method	of semic	onductor devi	ce	U	S.DEPT. OF COMM./PAT.\$ TM-PTO-436	SL(Rev. 12-
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THE OF ALL C	WANCE MAR ED	1 .	CLAIMS ALLOWED					
NOTICE OF ALLOWANCE MAILED		Assistant Examiner	Total Claims		Print Claim for O.G			
			DRAWING					
ISS Amount Due	UE FEE Date Paid	1	Shooto Droig.	Figs.Dr		Print Fig.		
		Primary Examiner		<u></u>				
TERMINAL DISCLAMER		PREPARED FOR ISSUE	ISSUE Application Examiner					
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